

| | | | | |
|-----------------------------------|--|---------------------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. 10/563,022 | Applicant(s)/Patent Under Reexamination EDELMANN ET AL. | |
| | | Examiner Alicia M. Toscano | Art Unit 1796 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|--|-----------------|-----------------|----------------|
| * | A US-6,699,586 | 03-2004 | Edelmann et al. | 428/447 |
| * | B US-2002/0197475 | 12-2002 | Edelmann et al. | 428/405 |
| * | C US-6,695,904 | 02-2004 | Burger et al. | 106/287.14 |
| * | D US-2003/0041779 | 03-2003 | Burger et al. | 106/287.14 |
| * | E US-6,830,816 | 12-2004 | Mehnert et al. | 428/423.1 |
| * | F US-2003/0008974 | 01-2003 | Mehnert et al. | 525/100 |
| * | G US-4,329,273 | 05-1982 | Hardman et al. | 524/862 |
| * | H US-5,021,091 | 06-1991 | Takarada et al. | 106/287.16 |
| I | US- | | | |
| J | US- | | | |
| K | US- | | | |
| L | US- | | | |
| M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|--|-----------------|---------|------|----------------|
| N | | | | | |
| O | | | | | |
| P | | | | | |
| Q | | | | | |
| R | | | | | |
| S | | | | | |
| T | | | | | |

NON-PATENT DOCUMENTS

| * | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|
| U | |
| V | |
| W | |
| X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.